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Houghton, A.W.; Reeve, C.D.;

Radar, Sonar and Navigation, IEE Proceedings - , Volume: 144 Issue: 6 , Dec. 1997
Page(s): 315 -320

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2 Precise measurement of arbitrary shaped and amplified femtosecond pulses

Takasago, K.; Yada, A.; Miura, T.; Washio, M.; Kannari, F.; Torizuka, K.; Endo, A.;
Lasers and Electro-Optics, 2001. CLEO/Pacific Rim 2001. The 4th Pacific Rim
Conference on , Volume: 2 , 15-19 July 2001
Page(s): II-732 -II-733 vol.2

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